## Notice of References Cited Application/Control No. 10/578,793 Applicant(s)/Patent Under Reexamination LUEG-ALTHOFF ET AL. Examiner TUYEN T. NGUYEN Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,042,411	05-2006	Yagi et al.	343/788
*	В	US-6,924,767	08-2005	Kitahara et al.	343/702
*	С	US-6,734,668	05-2004	Hils et al.	324/232
*	۵	US-4,907,346	03-1990	Watanabe, Yasuaki	33/361
*	Е	US-4,825,166	04-1989	MacGugan, Douglas C.	324/346
*	F	US-6,181,130	01-2001	Hoshi et al.	324/253
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	S					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.